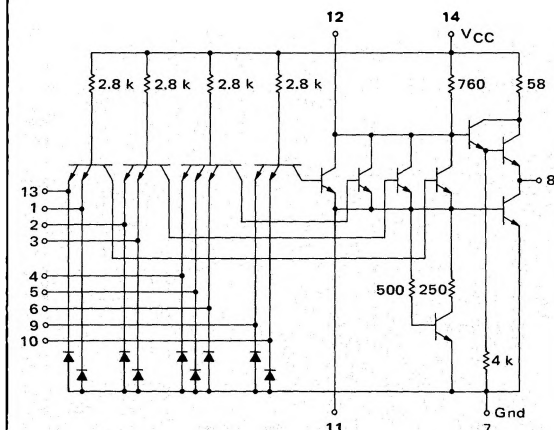


EXPANDABLE
4-WIDE 2-2-2-3-INPUT
"AND-OR-INVERT" GATE

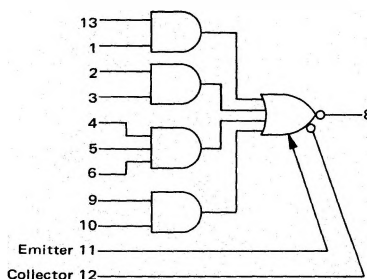
MC3100/MC3000 series

MC3132F • MC3032F
MC3132L • MC3032L,P
(54H53J) (74H53J, N)

CIRCUIT SCHEMATIC



This device consists of four 2-2-2-3-input AND gates ORed together and inverted. Up to four MC3120/3020 or one MC3118/3018 expander gates may be ORed with the device at the expander points.



Positive Logic:

$$8 = (13 \cdot 1) + (2 \cdot 3) + (4 \cdot 5 \cdot 6) + (9 \cdot 10) + (\text{Expanders})$$

Negative Logic:

$$8 = 13 + 1 + (2 + 3) + (4 + 5 + 6) + (9 + 10) + (\text{Expanders})$$

Input Loading Factor = 1

Output Loading Factor = 10

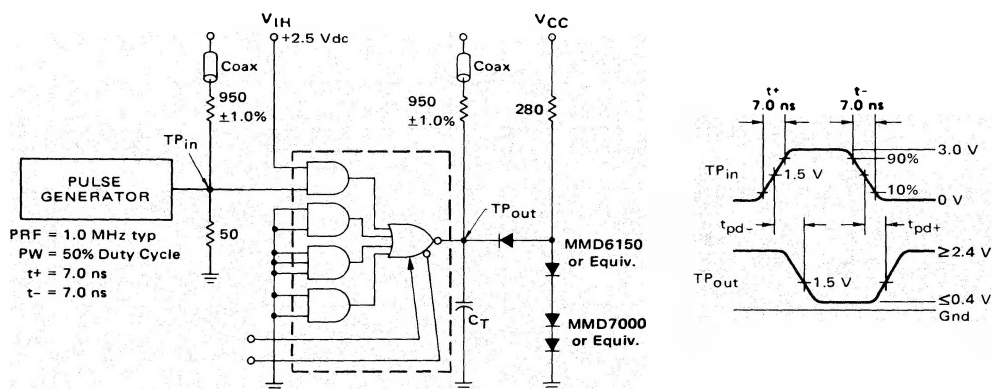
Total Power Dissipation = 40 mW typ/pkg

Propagation Delay Time = 7 ns typ

Pin numbers for the 54H53F/74H53F device are shown in the chart. These devices are available on special request.

DEVICE	PIN NUMBERS													
MC3132F,L/3032F,L,P	1	2	3	4	5	6	7	8	9	10	11	12	13	14
54H53F/74H53F	5	6	7	8	9	10	11	12	13	14	1	2	3	4

SWITCHING TIME TEST CIRCUIT AND WAVEFORMS



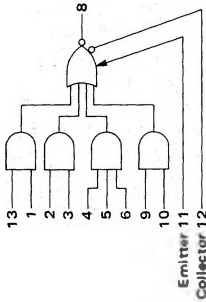
Expander pins should be left open when measuring switching times.

$C_T = 25 \text{ pF}$ = total parasitic capacitance, which includes probe, wiring, and load capacitances.

The coax delays from input to scope and output to scope must be matched. The scope must be terminated in 50 ohm impedance. The 950 ohm resistor and the scope termination impedance constitute a 20:1 attenuator probe. Coax shall be CT-070-50 or equivalent.

ELECTRICAL CHARACTERISTICS

Test procedures are shown for one input of the device. To complete testing, sequence through remaining inputs in the same manner.



TEST CURRENT/VOLTAGE VALUES (All Temperatures)													
Volts													
mA													
Ohms													
TEST CURRENT/VOLTAGE APPLIED TO PINS LISTED BELOW:													
Characteristic	Symbol	Pin Under Test	MC3132 Test Limits -55 to +125°C				MC3032 Test Limits 0 to +75°C				V _{IL}		
			Min	Max	Unit	Min	Max	Unit	Min	Max	V _{OH}	V _{CC}	V _{COH}
Input Forward Current	I _{IF}	1	-	-2.0	mAdc	-	-2.0	mAdc	-	-	-	-	-
Leakage Current	I _{IL}	1	-	50	μAdc	-	50	μAdc	-	-	-	-	-
Breakdown Voltage	BV _{in}	1	5.5**	-	mVdc	5.5**	-	mVdc	-	-	-	-	-
Clamp Voltage	V _{CL}	1	-	-1.5**	mVdc	-	-1.5**	mVdc	-	-	-	-	-
Expander Input Current	I _{EX}	12 (1)	-	-3.05	mAdc	-	-6.3	mAdc	-	-	-	-	-
Base-Emitter Voltage	V _{BE}	11 (2)	-	1.0	Vdc	-	1.0	Vdc	-	-	-	-	-
Output	V _{OL}	8	-	0.4	Vdc	-	0.4	Vdc	-	-	-	-	-
		8 (2)	-	0.4	Vdc	-	0.4	Vdc	-	-	-	-	-
		8	2.4	-	Vdc	2.4	-	Vdc	-	-	-	-	-
		8	2.4	-	Vdc	2.4	-	Vdc	-	-	-	-	-
Short-Circuit Current	I _{SC}	8	-20	-55	mAdc	-11	-55	mAdc	-	-	-	-	-
Power Requirements													
Power Supply Drain	I _{PDH}	14	-	14	mAdc	-	14	mAdc	-	-	-	-	-
Switching Parameters	t _{pdL}	14	-	11	ns	-	11	ns	-	-	-	-	-
		1, 8	-	11**	ns	-	11**	ns	-	-	-	-	-
		1, 8	-	11**	ns	-	11**	ns	-	-	-	-	-
		1, 8	-	11**	ns	-	11**	ns	-	-	-	-	-

**Tested only at 25°C

† Expander pins open

① See Figure 1.

② See Figure 2.

③ See Figure 3.

FIGURE 1 – I_{EX} TEST CIRCUIT

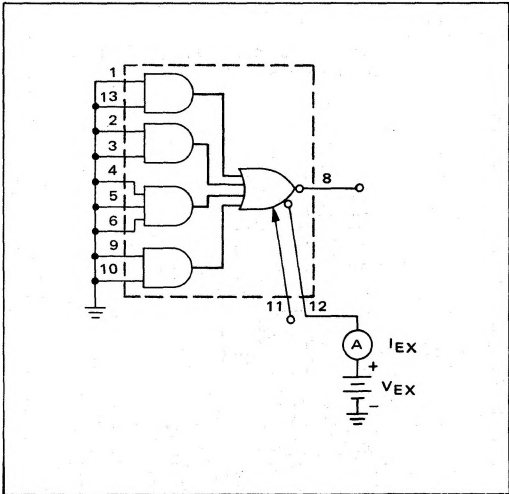


FIGURE 2 – V_{BE} TEST CIRCUIT

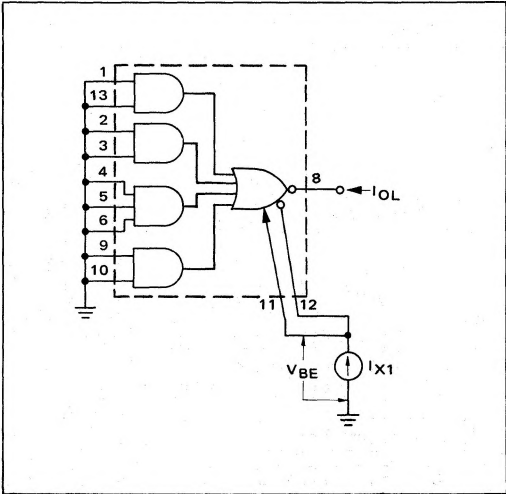


FIGURE 3 – V_{OL} TEST CIRCUIT

